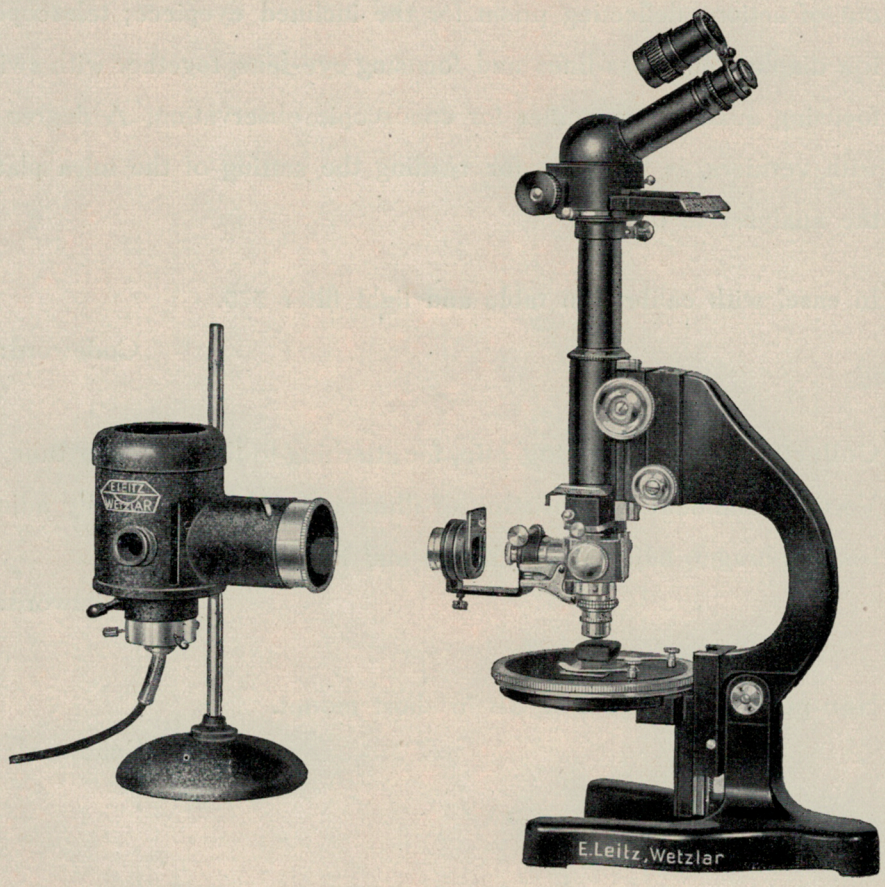
Leitz

Elliptical Analyser

for the quantitative Determination of Anisotropy in Incident Polarised Light.



E. Leitz, Inc. 730 Fifth Avenue, New York, N.Y.

Leitz

Elliptical Analyser for the Determination of Anisotropy in Incident Polarised Light.

Eyepiece with Elliptical Analyser,* consisting of non-polarising eyepiece; mica plate and analyser, each with device for rotating and putting in and out of action; deflecting prism for the inclined eyepiece; telescope with iris diaphragm, cross-lines and focusing eye-lens, together with swing-in, focusing auxiliary magnifier for conoscopic observation. A degree scale, with verniers, is provided for reading the setting of the mica plate and the analyser to 0.1°.

In case, with calibration table and light filter 575.

Codeword: **iiceg** £ 250.00

Collecting lens on spring clip, for attaching to the entrance tube of the Vertical Illuminator, consisting of illuminating lens, vertically adjustable iris diaphragm, adjustable half-stop and filter holder.

Codeword: **iicay** 27.—

Non-polarising objective 3b in short mount.

Codeword: **iicwq** 15.—

* For Stand MOP with compensating prism in the Vertical Illuminator. In all other cases the stand must be sent to us for the necessary adaptation. Concerning this point and the method of measuring, see M. Berek: "Optische Messmethoden im polarisierten Auflicht", publ. by the deutsche Mineralogische Gesellschaft, 1937 (G. Fischer, Jena).

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